

Progress Towards Cryo FIB Lift-Out

Cheryl Hartfield, Oxford Instruments

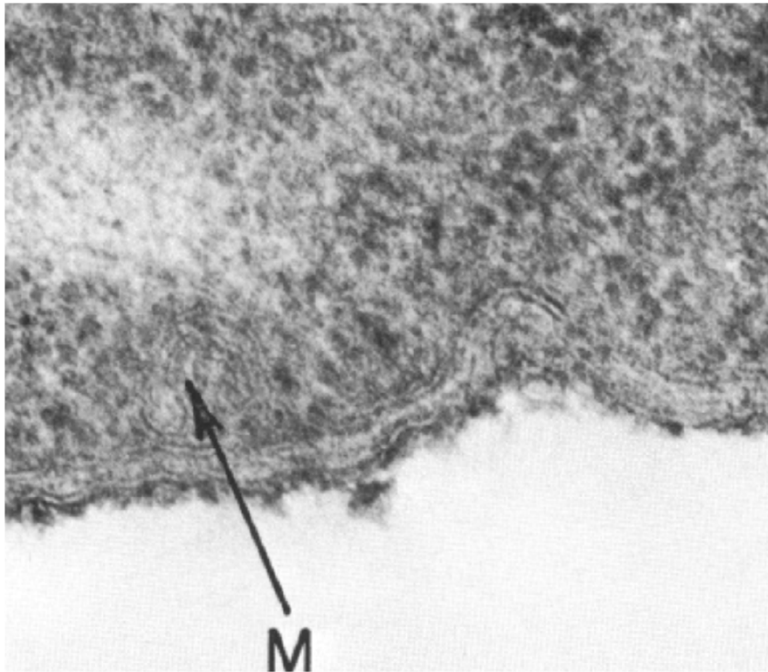
Nicholas Antoniou, Harvard University

Jeff Ditto, University of Oregon, CAMCOR

6th North American FIB-SEM Workshop, March 1, 2013, Cambridge, MA

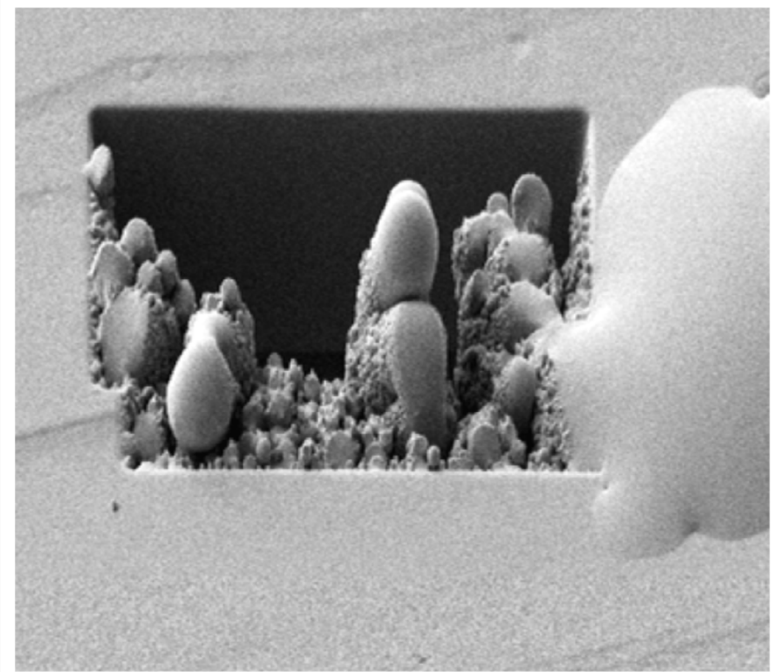
1st Rule of Sample Preparation: DO NO HARM

Biological



Chemical fixation can induce artifacts, such as the bacterial mesosome

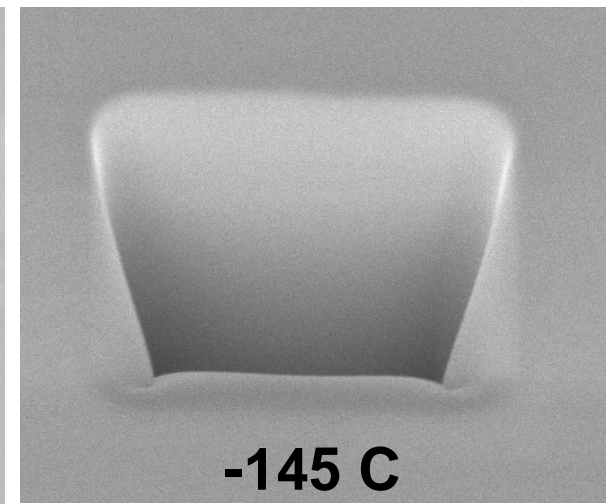
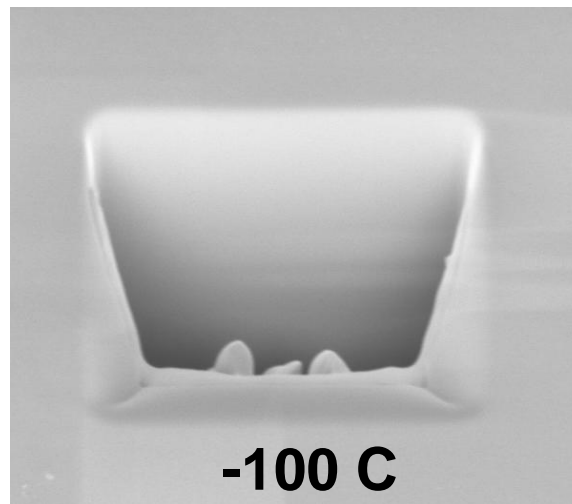
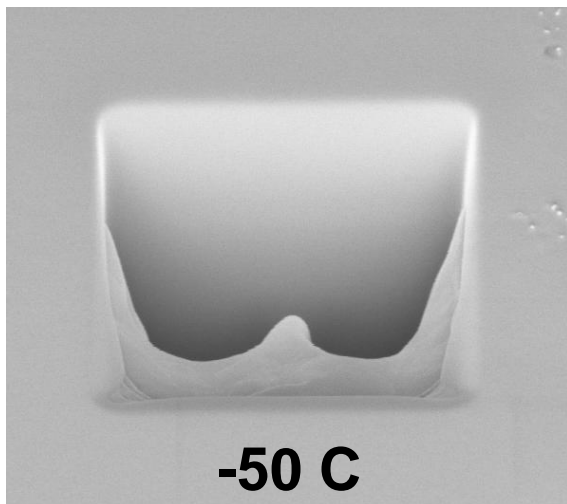
III-V Materials



Room temperature promotes undesirable Ga+ reactions during and after ion milling

GaN FIB Milling Temperature

Temperature (C)	Exposure (nC/ μm^2)	Side Effect (Qualitative)
0 C	5.5	Severe
-25 C	5.5	Severe
-50 C	5.5	Intermediate
-100 C	5.5	Minimized
-145 C	5.5	None Observed



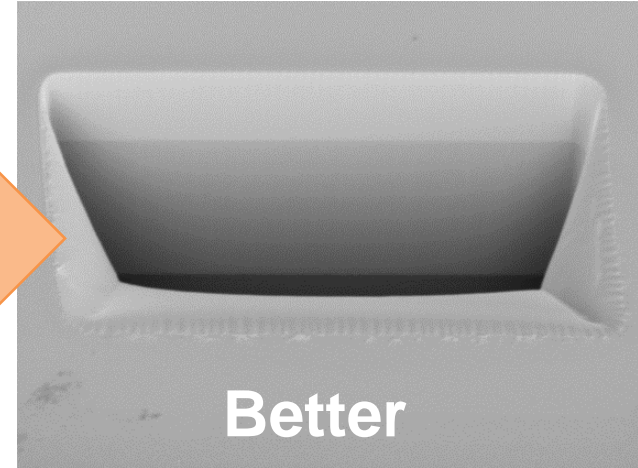
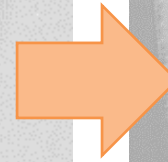
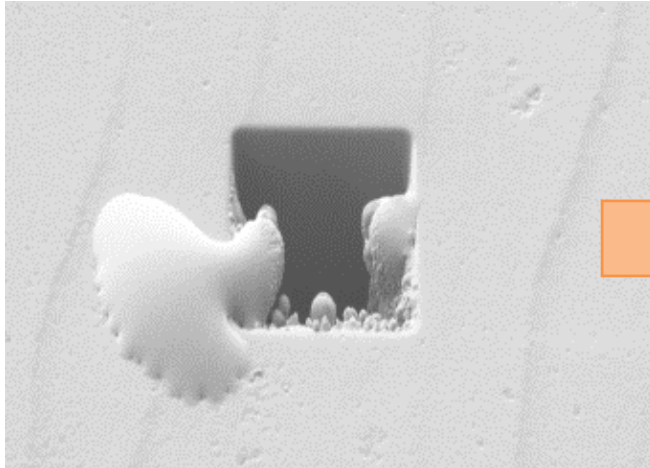
FIB Milling Temperature Effects

(Dose: $5.5 \text{ nC}/\mu\text{m}^2$)

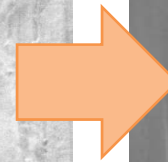
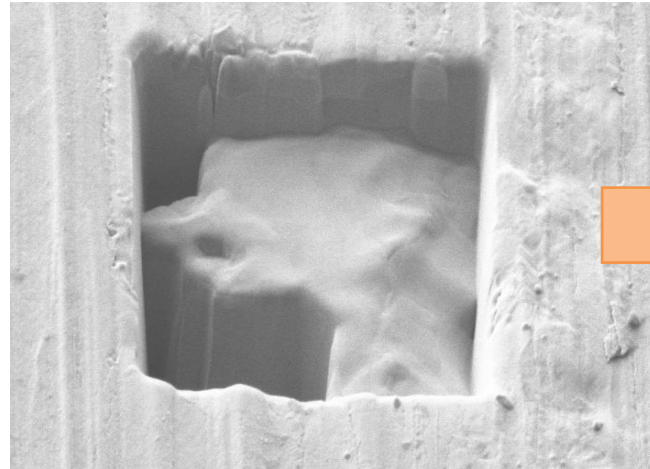
Room Temperature

-145° C

- GaN

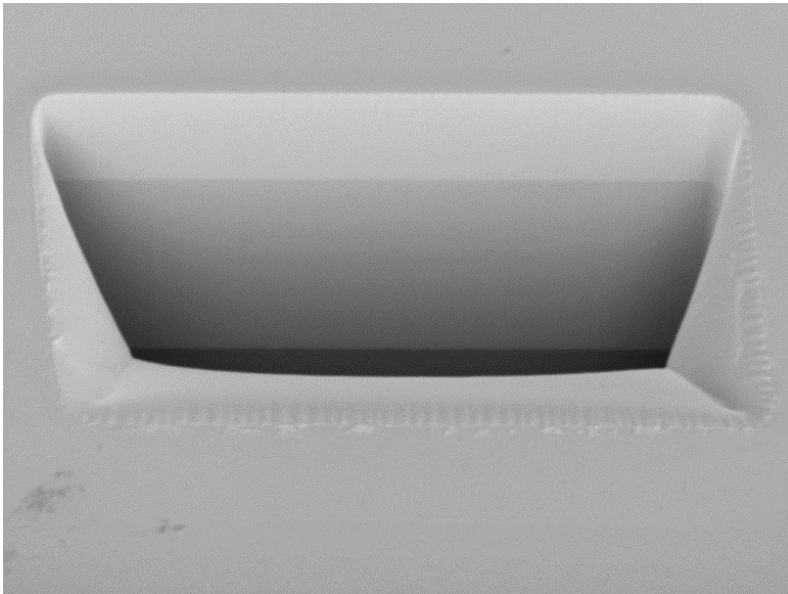


- Copper

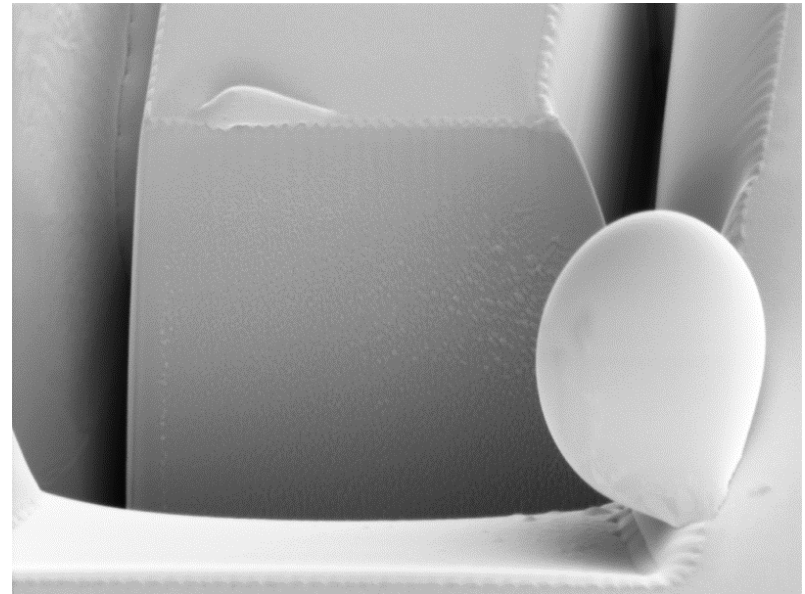


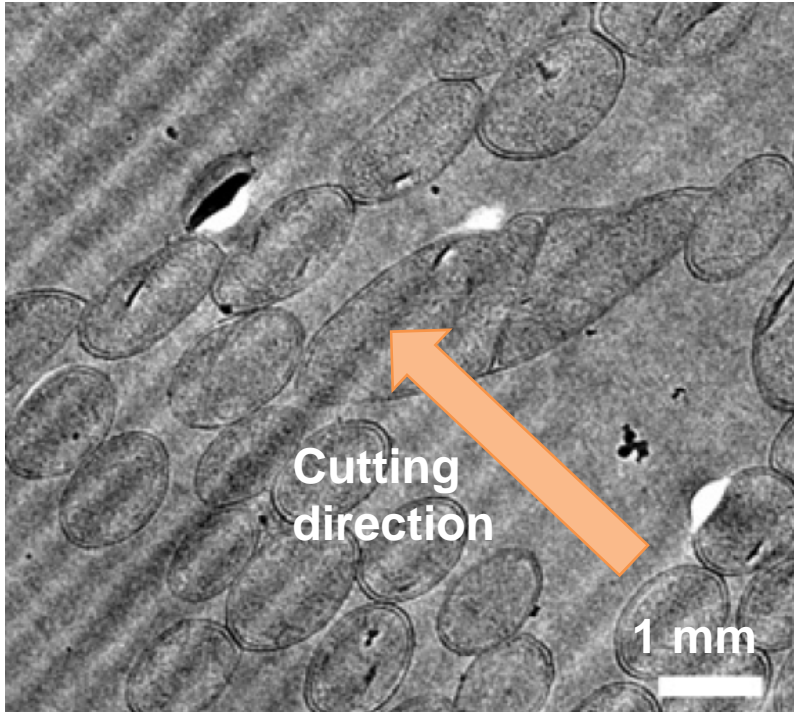
- Samples cryo-milled (-145°C)
- Dose: $5.5 \text{ nC}/\mu\text{m}^2$

Imaged at -145°C



Imaged at Room Temp

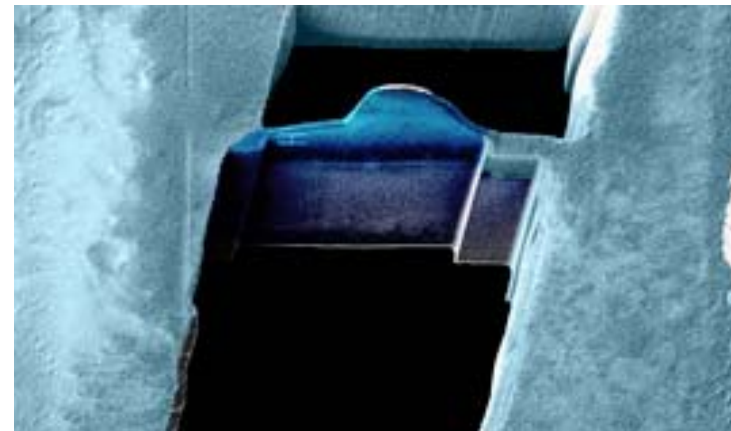
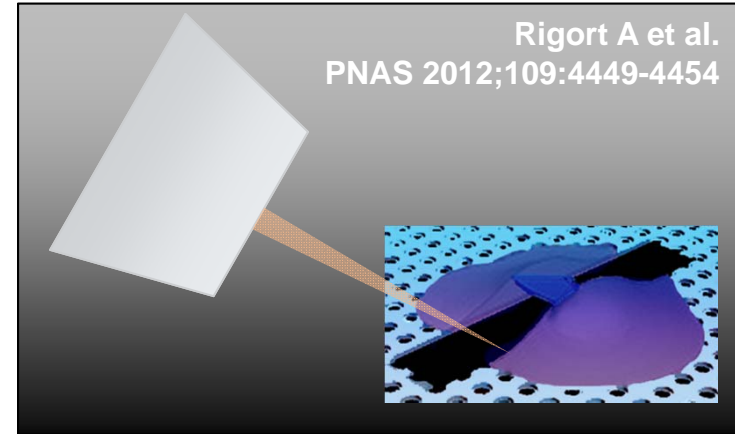




<http://dx.doi.org/10.1016/j.jsb.2010.02.011>

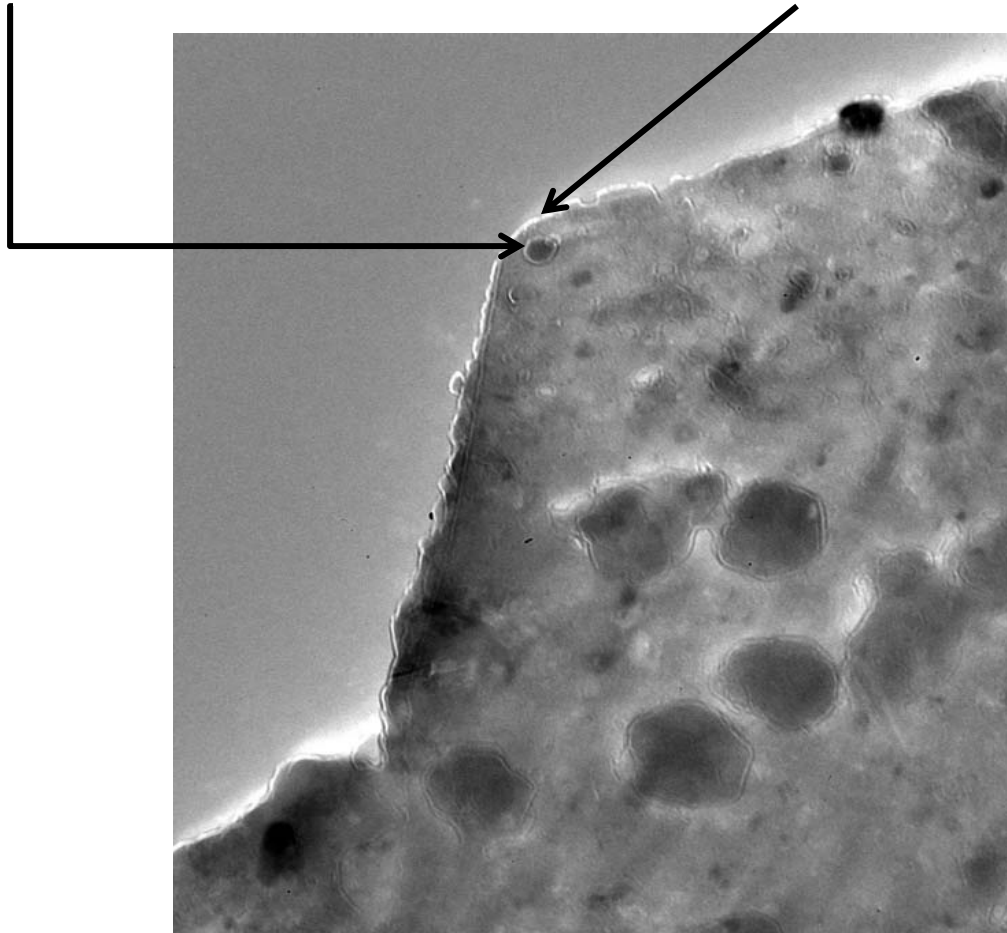
Cryoultramicrotome sections may have severe (70%) compression

Bio Cryo FIB H-Bar Prep



Cryo-TEM of Cryo-FIB Prepared Sample

Polio virus inside cell membrane



Benefits

- One protocol for many samples (all sizes, types and industries)
- Site-specific and can position for SIMS, EDS, EBSD etc.
- Custom shaping: micropillar tomography specimens to avoid missing wedge

Challenges

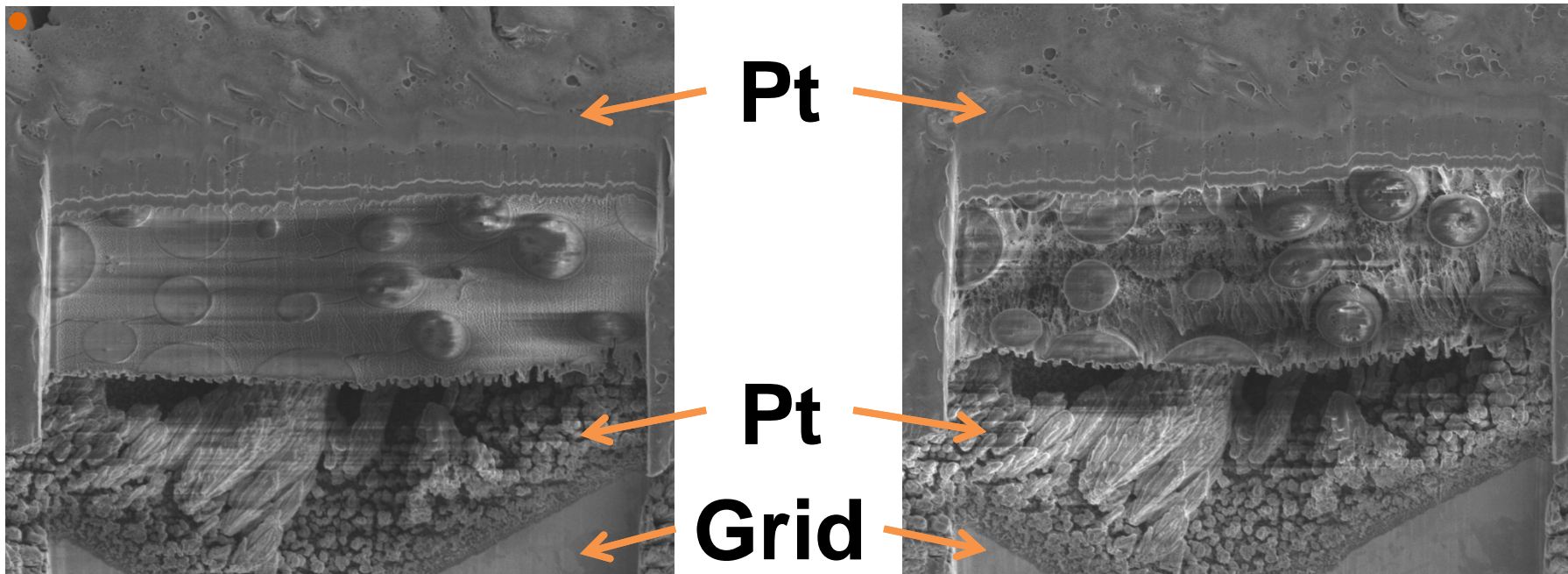
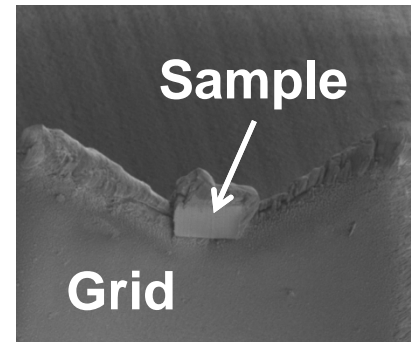
- Ga⁺ implantation and curtaining
- Condensing behavior of standard gases
- Keeping sample below -138°C for all steps
- Education

Biological Sample Beam Control

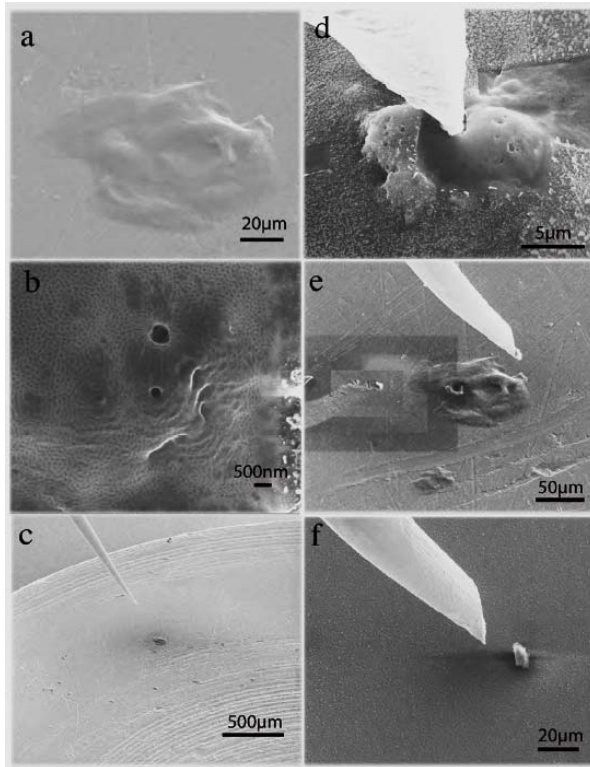
Baker's yeast in aqueous suspension

9.3nA trench milling too aggressive

- Use low dose rate **~2 ions/nm²/s**
- For a 20 μm^2 area of E. coli suspension:
 - Two minutes to thin 1100nm to 500nm

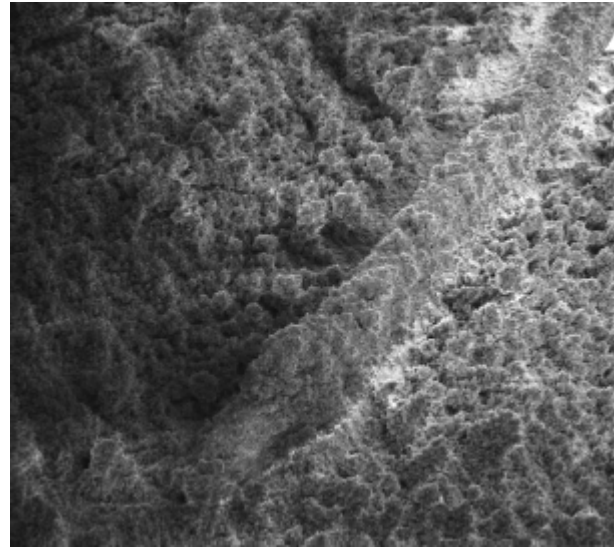


Dig and Shovel



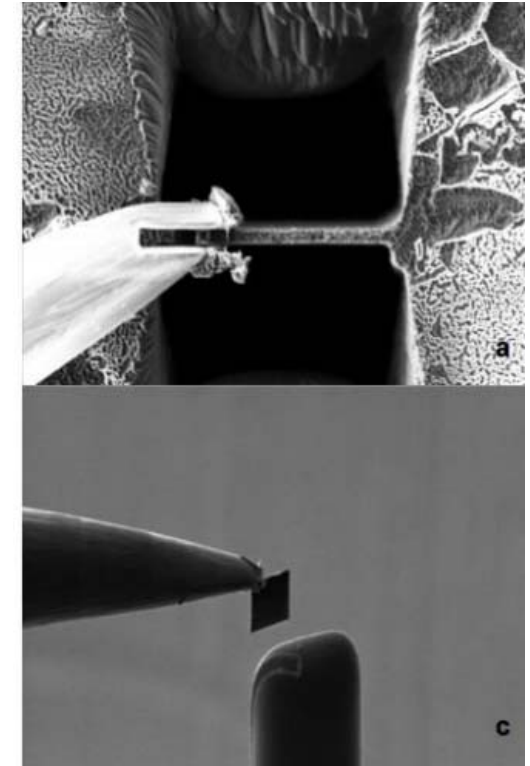
J. McGeoch, 2007
10.1111/j.1365-2818.2007.01798.x

Platinum Attach



MF Hayles et al., 2007
10.1111/j.1365-2818.2007.01775.x

Force Friction



A Sehrbrock et al., 2011
MC2011 Poster



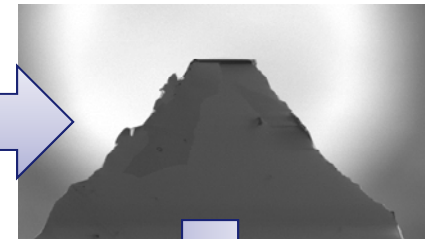
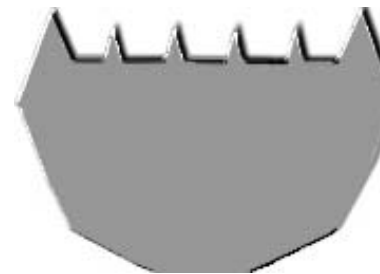
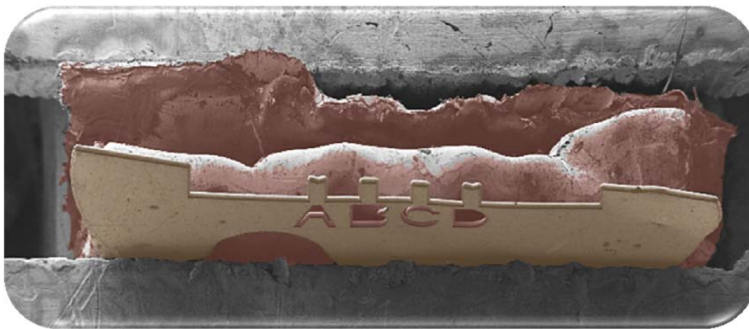
Harvard University CNS

- Leica EM VCT100 Cryo Transfer
- Zeiss Nvision
- OmniProbe 300

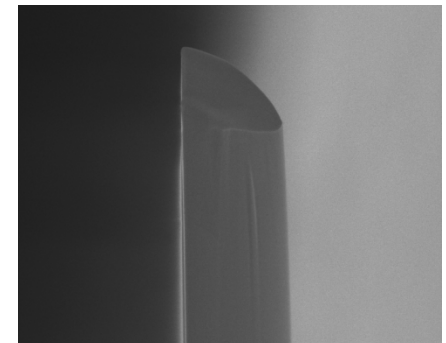


Silicon Half Grids: Rigid Substrates for Cryo Lift-Out

Include photo of new shape for easier TEM holder loading

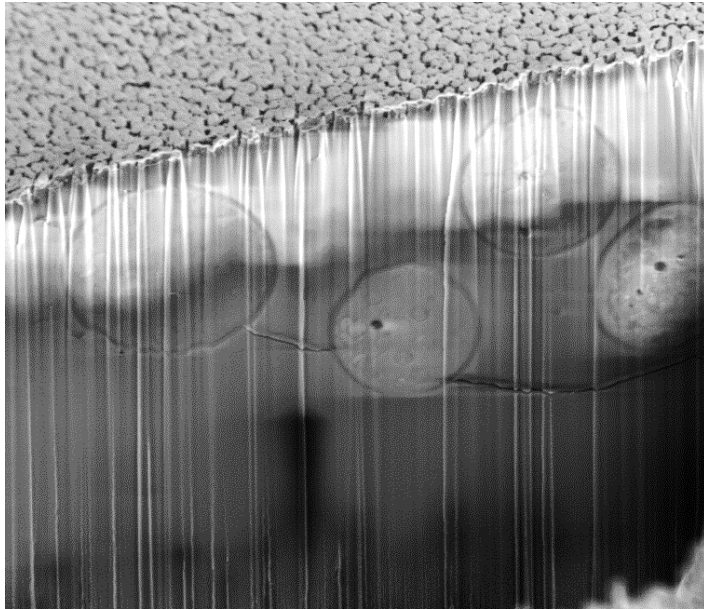


**FIB modification
(<10 mins)**

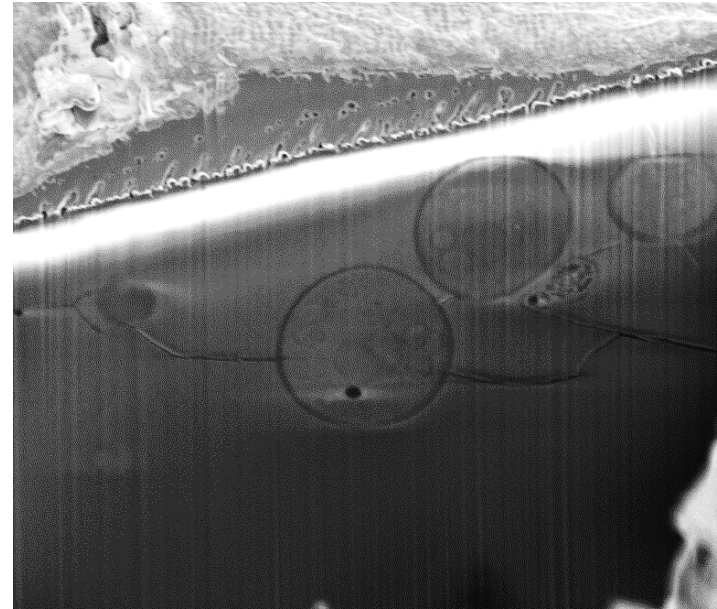


- **Platinum precursor improves curtain artefacts**

No Precursor



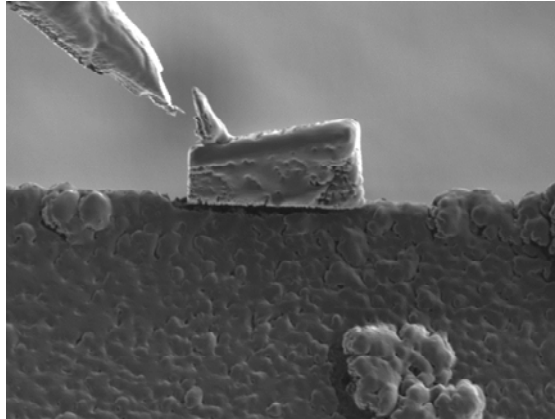
With Precursor



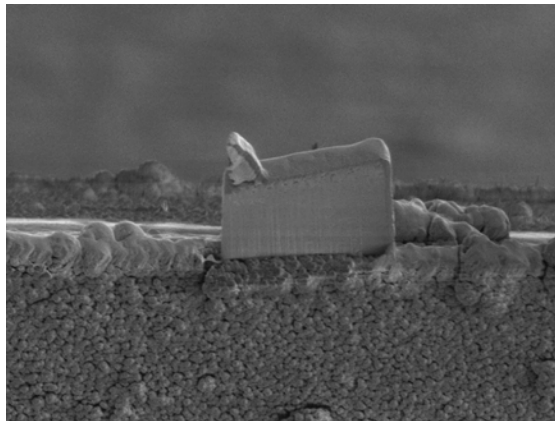
- **Global condensation is controlled by:**
 - **Temperature (use Pt at 27C)**
 - **Distance (gas nozzle 3mm from sample)**
 - **Time (a few seconds)**

Early Work Used Pt

- **Tip Attach**



- **Grid Attach**

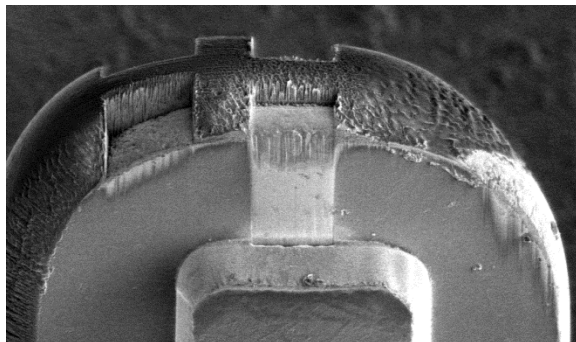


New Improvements

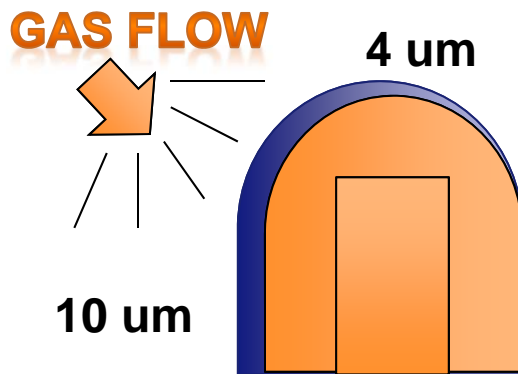
- **Attach using ice condensation**
- **The tip is clean and ‘like new’ upon warming**
- **Simultaneously attach with ice & separate the tip**
- **Adding Pt (100nm) reduces curtains**

Mitigates thermal drift

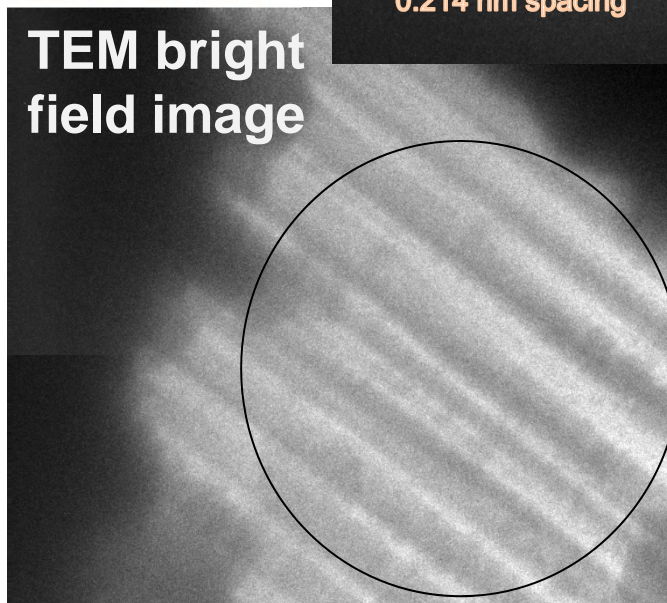
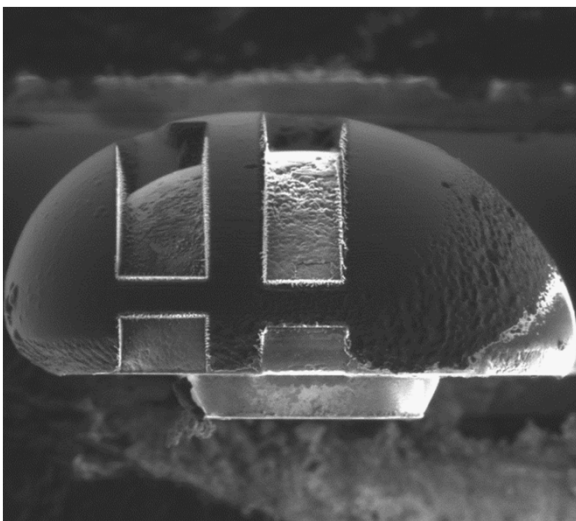
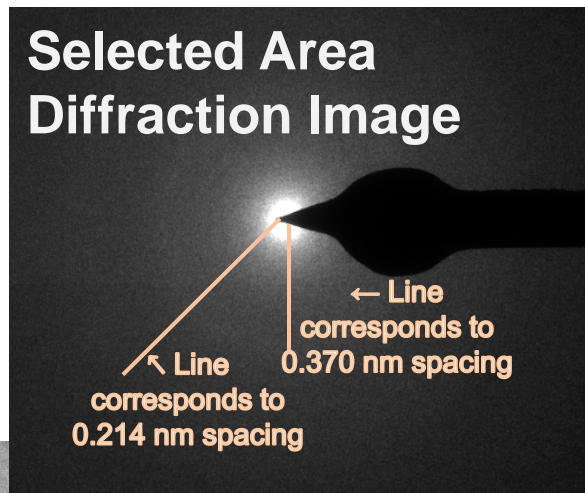
Amorphous Ice Confirmed



H-bar lamella for TEM diffraction



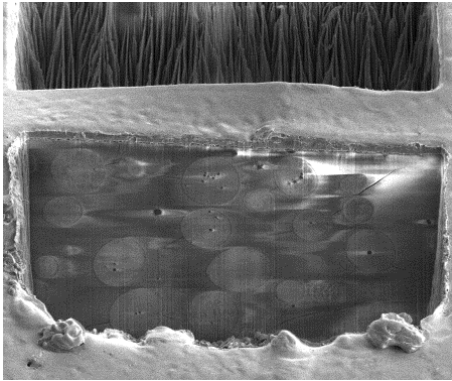
FACE OF GRID POST



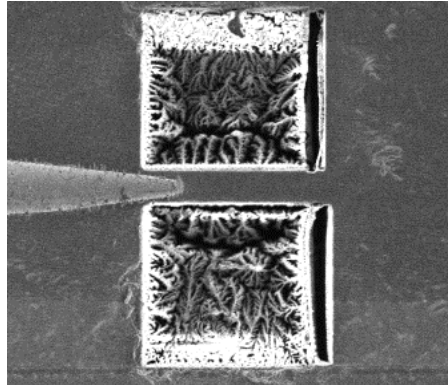
TEM bright field image

Cryo Lift-Out (CAMCOR)

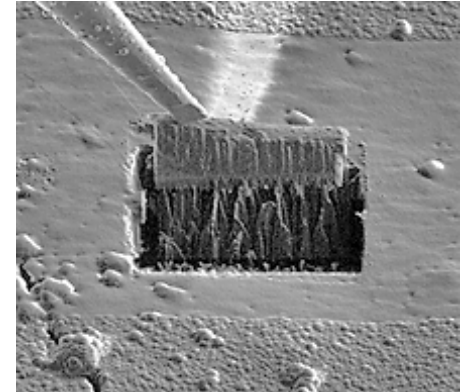
Site of Interest



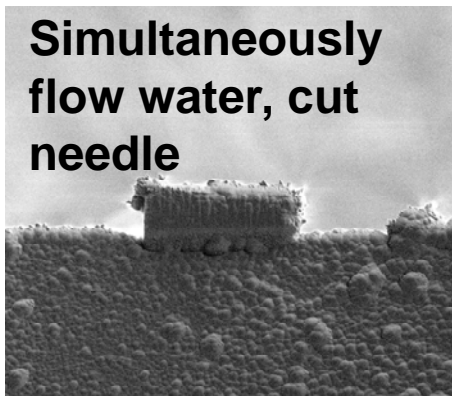
Probe Contact



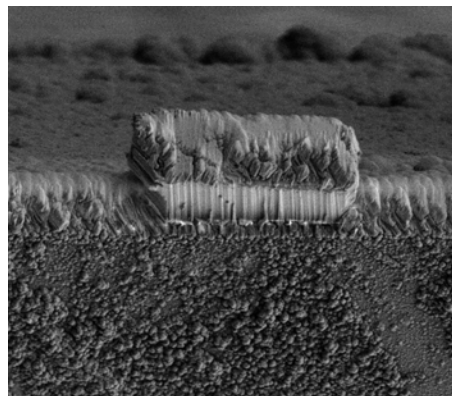
Water Attach & Lift



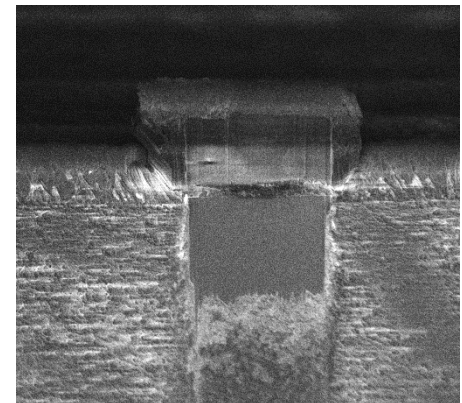
Grid Attach



Platinum Coat

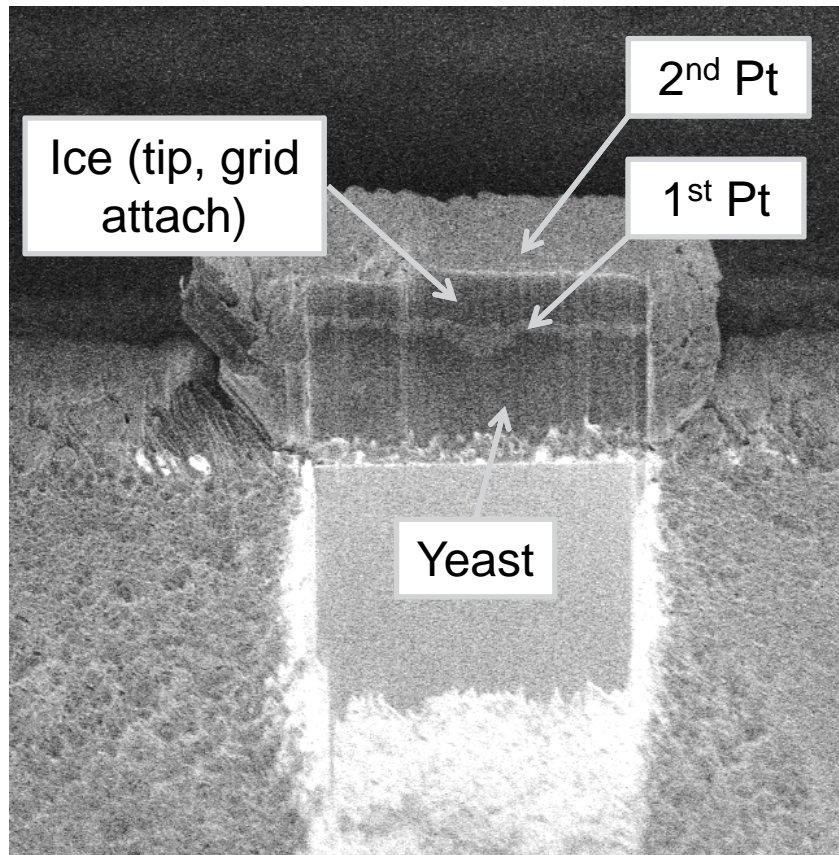


Clean and Thin

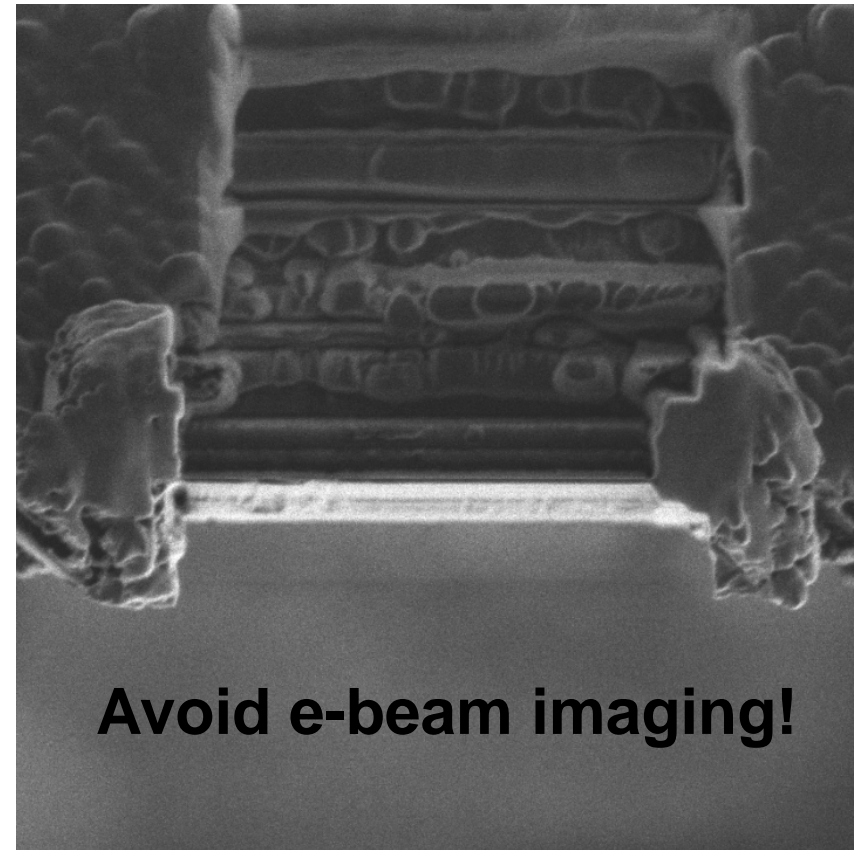


Avoid e-beam
during thinning!

Lift-Out Sample Structure



Final Thinning, Ion Beam View



- **Cryo FIB is useful for both materials and biological samples**
- **Progress has been made in cryo lift-out methods and hardware**
 - Cooled manipulator tip assembly
 - Robust lift-out grids
 - “Ice welding”
 - Managing the beam
- **Method refinements continue**

- **Dr. Kamal Baloch (Harvard) for the GaN samples**
- **Dr. Kim Rensing (Leica) for sharing his cryo-EM experience**
- **Ms. Christalyn Sims (Harvard) for the cryo-TEM image**
- **Gonzalo Amador (Oxford Instruments) for the cryo tip assembly**
- **Funding Entities**
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